Application/Control No. Applicant(s)/Patent Under Reexamination 10/511,792 RADENNE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2815 Chris C. Chu **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY * 04-2001 156/73.1 US-6,217,685 Leydier et al. Α US-В С US-US-D US-E US-F US-G US-Н USı US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S Т **NON-PATENT DOCUMENTS**

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